



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of

OGO et al

Atty. Ref.: 1035-654

Serial No. 10/590,939

TC/A.U.: Unknown

Filed: August 28, 2006

Examiner: Unknown

For: APPARATUS AND METHOD FOR ABSORPTION, EMISSION, AND  
SCATTERING SPECTROSCOPY WITH SUBSTANTIALLY SIMULTANEOUS MASS  
SPECTROMETRY, AND APPARATUS AND METHOD FOR MASS  
SPECTROMETRY BASED ON ELECTROSPRAY IONIZATION

\* \* \* \* \*

September 5, 2007

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

SECOND SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

As suggested by 37 C.F.R. 1.97, the undersigned attorney brings to the attention of the Patent and Trademark Office the references listed on the attached form PTO/SB/08a. Copies of the International Search Report and each if the listed foreign patent documents are attached.

This is not to be construed as a representation that a search has been made or that no better prior art exists, or that a reference is relevant merely because cited.

The Examiner is requested to initial the attached form PTO/SB/08a and to return a copy of the initialed document to the undersigned as an indication that the attached references have been considered and made of record.

Respectfully submitted,

NIXON & VANDERHYE P.C.

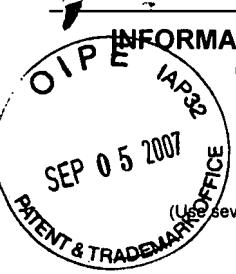
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Sheet 1 of 4



**INFORMATION DISCLOSURE  
CITATION**

ATTY. DOCKET NO.

SERIAL NO.

1035-654

## Unknown

**APPLICANT**

OGO et al

**FILING DATE**

TC/A.U.

August 28, 2006

## Unknown

## U.S. PATENT DOCUMENTS

## FOREIGN PATENT DOCUMENTS

DOCUMENT		DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES	TRANSLATION NO
	2002-015697A	12/2002	Japan			x	
	2002-190272A	06/2001	Japan			x	
(Translations are provided of Japan Patent Office		by Industrial Property Digital Library (JPO))	(IPDL)				

**OTHER DOCUMENTS (including Author, Title, Date, Pertinent pages, etc.)**

\*Examiner

### Date Considered

Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to application.